

## Supporting Information

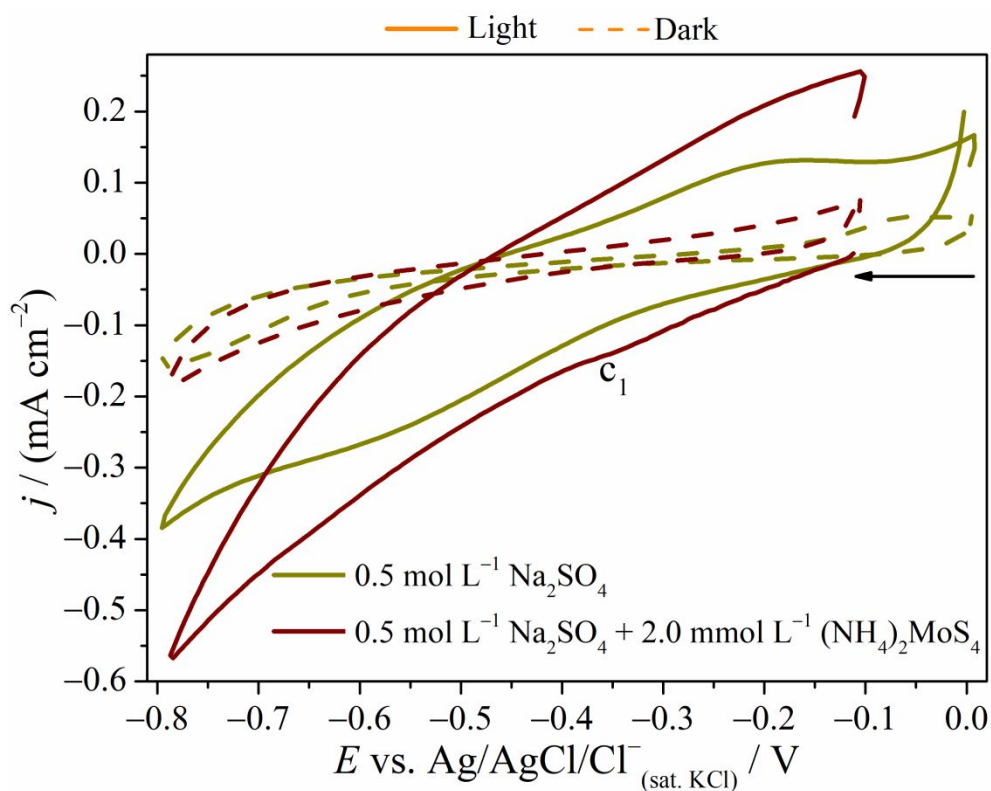
### Improved Photoelectrochemical Hydrogen Gas Generation on $\text{Sb}_2\text{S}_3$ Films Modified with an Earth-Abundant $\text{MoS}_x$ Co-Catalyst

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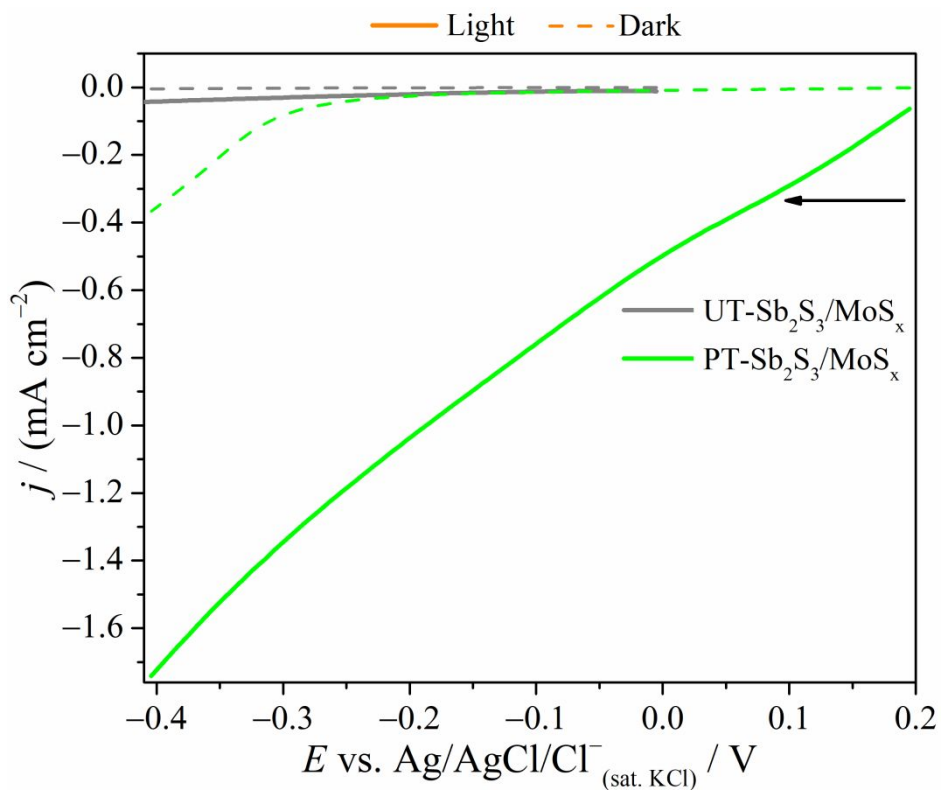
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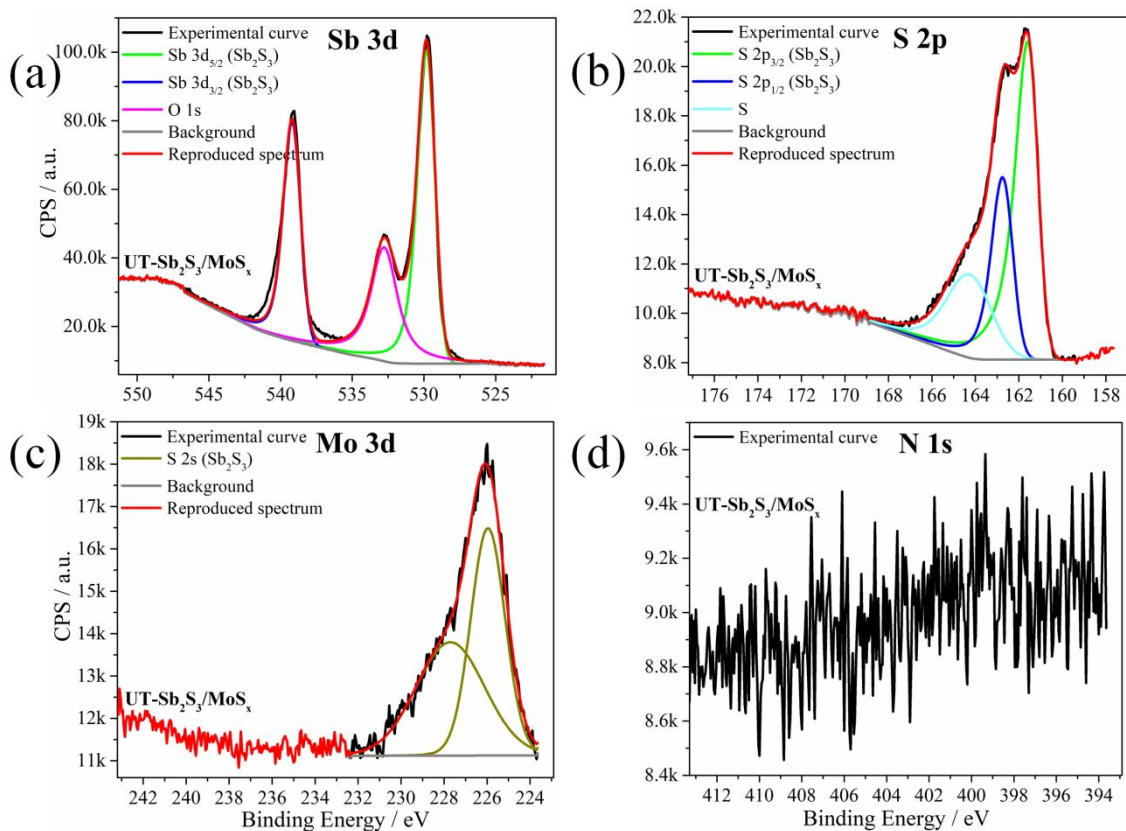
**Figure S1.** Cyclic voltammograms at a scan rate of 20 mV s<sup>-1</sup> in the dark and under solar light simulator (AM1.5G and 100 mW cm<sup>-2</sup>) for PT-Sb<sub>2</sub>S<sub>3</sub> film in 0.5 mol L<sup>-1</sup> Na<sub>2</sub>SO<sub>4</sub> pH 5 and 0.5 mol L<sup>-1</sup> Na<sub>2</sub>SO<sub>4</sub> + 2.0 mmol L<sup>-1</sup> (NH<sub>4</sub>)<sub>2</sub>MoS<sub>4</sub> pH 5.

According to Figure S1, the voltammogram obtained under illumination for PT-Sb<sub>2</sub>S<sub>3</sub> film in 0.5 mol L<sup>-1</sup> Na<sub>2</sub>SO<sub>4</sub> + 2.0 mmol L<sup>-1</sup> (NH<sub>4</sub>)<sub>2</sub>MoS<sub>4</sub> displayed a shoulder cathodic peak  $c_1$  at ca. -0.35 V. Since this peak was not observed in the voltammogram under illumination for PT-Sb<sub>2</sub>S<sub>3</sub> film in only 0.5 mol L<sup>-1</sup> Na<sub>2</sub>SO<sub>4</sub>, the shoulder peak  $c_1$

was assigned to the PEC reduction of  $[\text{MoS}_4]^{2-}$  as shown in Equation 1 in the manuscript.



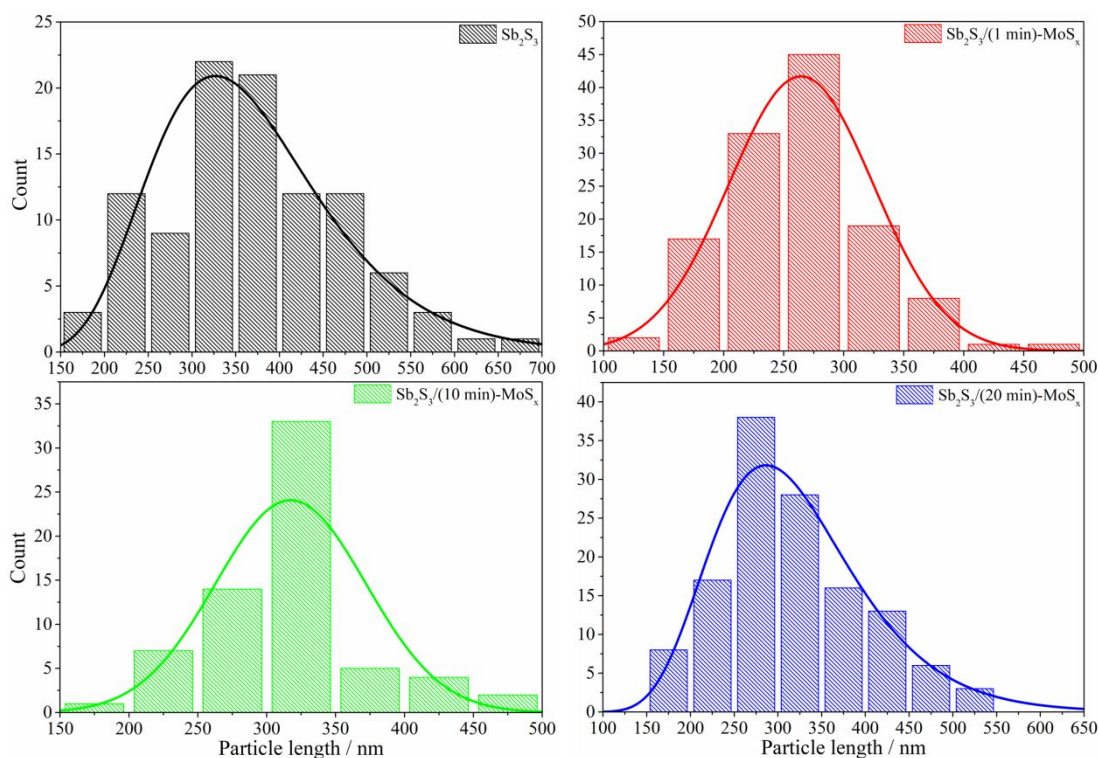
**Figure S2.** Linear sweep voltammograms at a scan rate of  $50 \text{ mV s}^{-1}$  in the dark and under solar light simulator (AM1.5G and  $100 \text{ mW cm}^{-2}$ ) for UT- $\text{Sb}_2\text{S}_3/\text{MoS}_x$  and PT- $\text{Sb}_2\text{S}_3/\text{MoS}_x$  films. The electrolyte was an  $\text{N}_2$ -saturated solution of  $1.0 \text{ mol L}^{-1} \text{ H}_2\text{SO}_4$  at pH 0.6. The  $\text{MoS}_x$  was photoelectrodeposited on the UT- $\text{Sb}_2\text{S}_3$  and PT- $\text{Sb}_2\text{S}_3$  films for 10 min.



**Figure S3.** High-resolution XPS spectra of (a) Sb 3d, (b) S 2p, (c) Mo 3d, and (d) N 1s core levels for UT-Sb<sub>2</sub>S<sub>3</sub>/MoS<sub>x</sub> film. The MoS<sub>x</sub> was photoelectrodeposited on the UT-Sb<sub>2</sub>S<sub>3</sub> film for 10 min.

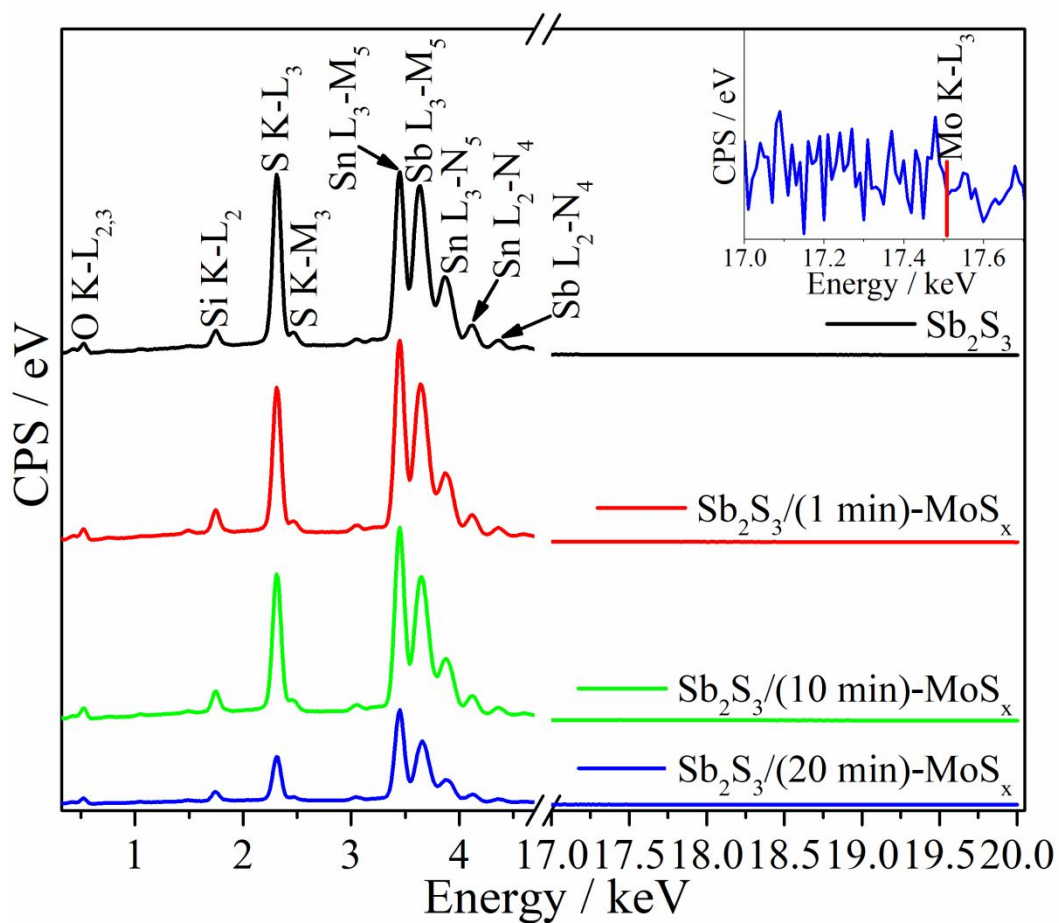
From Figure S3a, the Sb 3d spectrum for the UT-Sb<sub>2</sub>S<sub>3</sub>/MoS<sub>x</sub> film presented photoemission peaks at 529.6 (Sb 3d<sub>5/2</sub>) and 539.0 eV (Sb 3d<sub>3/2</sub>), which are assigned to Sb<sup>3+</sup> in Sb<sub>2</sub>S<sub>3</sub>.<sup>1</sup> Additionally, the spectrum displayed a photoemission peak at 532.8 eV

(O 1s) and that is probably associated with adsorbed water.<sup>2</sup> The S 2p spectrum for the UT-Sb<sub>2</sub>S<sub>3</sub>/MoS<sub>x</sub> film (cf. Figure S3b) displayed photoemission peaks at 161.4 (S 2p<sub>3/2</sub>) and 162.6 eV (S 2p<sub>1/2</sub>) which are characteristic for S<sup>2-</sup> in Sb<sub>2</sub>S<sub>3</sub>.<sup>3</sup> The additional peak at 163.9 eV is probably attributed to residual elemental sulphur<sup>4</sup> on the Sb<sub>2</sub>S<sub>3</sub> films' surface and this may have come from the sulphurisation step. For the Mo 3d spectrum in Figure S3c, one can observe the photoemission peaks at 226.0 and 227.7 eV for S 2s,<sup>5</sup> which are possibly assigned to Sb<sub>2</sub>S<sub>3</sub>. The N 1s spectrum (see Figure S3d) did not display any photoemission signal. This result was already expected for the UT-Sb<sub>2</sub>S<sub>3</sub>/MoS<sub>x</sub> film since the Sb<sub>2</sub>S<sub>3</sub> film was not subjected to N<sub>2</sub> plasma treatment. We only observed photoemission peak in the N 1s region for the Sb<sub>2</sub>S<sub>3</sub> films once treated under N<sub>2</sub> plasma, for more details the reader is referred to our latest work<sup>6</sup> and the discussion of Figure 4 in this manuscript.



**Figure S4.** Particle size distribution histograms for PT-Sb<sub>2</sub>S<sub>3</sub> and PT-Sb<sub>2</sub>S<sub>3</sub>/(1, 10, or 20 min)-MoS<sub>x</sub> films.

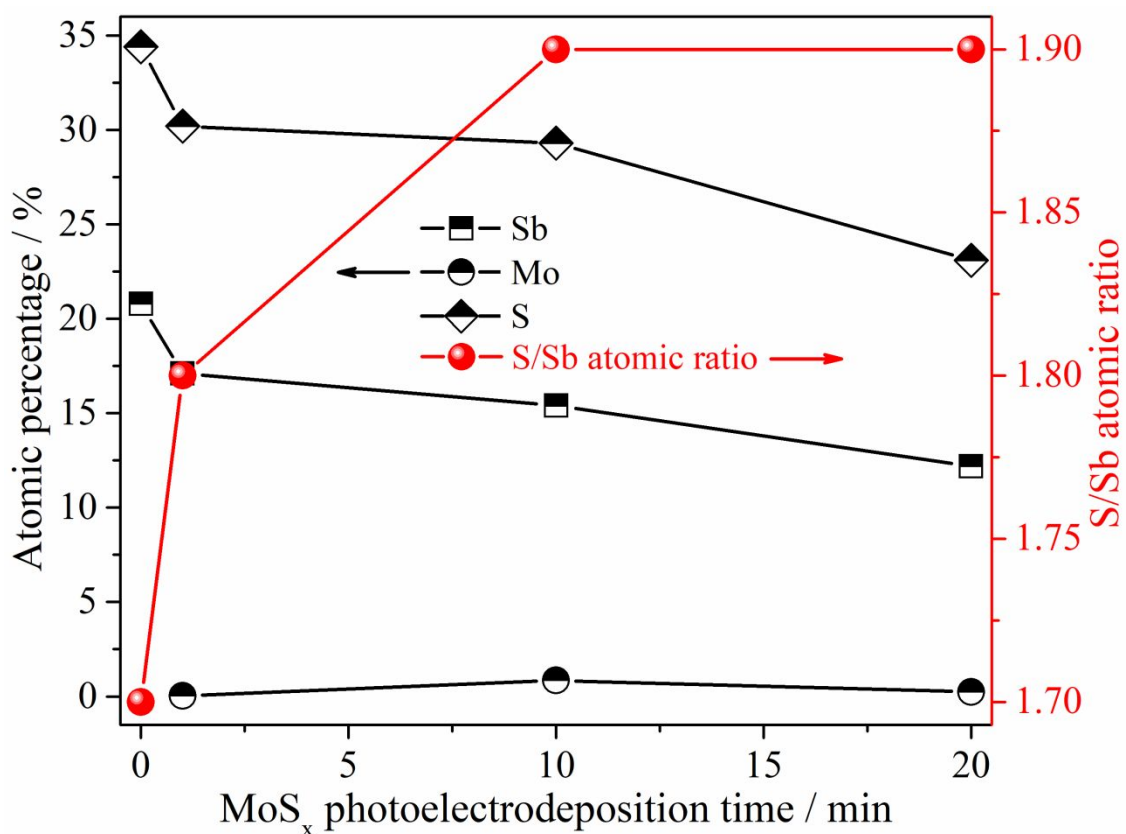
To obtain the particle size distribution, histograms were constructed and are displayed in Figure S4. We employed the ImageJ<sup>7,8</sup> (version 1.51j8) software to measure the length of up to 130 particles from the SEM micrographs. According to Figure S4, the estimated particle length for bare PT-Sb<sub>2</sub>S<sub>3</sub> film was 325 nm, whilst the particle length for PT-Sb<sub>2</sub>S<sub>3</sub> films superficially modified with MoS<sub>x</sub> photoelectrodeposited for 1, 10, and 20 min was ca. 275, 325, and 275 nm, respectively.



**Figure S5.** EDS spectra for PT-Sb<sub>2</sub>S<sub>3</sub> and PT-Sb<sub>2</sub>S<sub>3</sub>/(1, 10, or 20 min)-MoS<sub>x</sub> films. The characteristic X-ray emission lines energies of the elements were assigned using Grieken and Markowicz's database.<sup>9</sup> The peaks assigned to the O, Si, and Sn elements are from the substrate (glass/FTO).

**Table S1.** Atomic percentage of Sb and S obtained from the EDS spectra for PT-Sb<sub>2</sub>S<sub>3</sub> and PT-Sb<sub>2</sub>S<sub>3</sub>/(1, 10, or 20 min)-MoS<sub>x</sub> films.

Sample	Atomic percentage / %		Atomic ratio
	Sb	S	S/Sb
Sb <sub>2</sub> S <sub>3</sub>	21	34	1.6
Sb <sub>2</sub> S <sub>3</sub> /(1 min)-MoS <sub>x</sub>	17	30	1.8
Sb <sub>2</sub> S <sub>3</sub> /(10 min)-MoS <sub>x</sub>	15	29	1.9
Sb <sub>2</sub> S <sub>3</sub> /(20 min)-MoS <sub>x</sub>	12	23	1.9



**Figure S6.** Atomic percentage of Sb, Mo and S, and S/Sb atomic ratio obtained from the EDS spectra for PT-Sb<sub>2</sub>S<sub>3</sub> and PT-Sb<sub>2</sub>S<sub>3</sub>/(1, 10, or 20 min)-MoS<sub>x</sub> films.



**Table S2.** Binding energy assignment from the high-resolution XPS spectra for PT-Sb<sub>2</sub>S<sub>3</sub> and PT-Sb<sub>2</sub>S<sub>3</sub>/(1 or 10 min)-MoS<sub>x</sub> films.

Core level	Binding energy / eV			Assignment	Ref.	
	PT-Sb <sub>2</sub> S <sub>3</sub>	PT-Sb <sub>2</sub> S <sub>3</sub> /(1 min)-MoS <sub>x</sub>	PT-Sb <sub>2</sub> S <sub>3</sub> /(10 min)-MoS <sub>x</sub>			
Sb 3d	Sb 3d <sub>3/2</sub>	540.4	539.9	539.2	Sb <sub>2</sub> S <sub>3</sub>	10,11
	Sb 3d <sub>5/2</sub>	531.0	530.5	529.8	Sb <sub>2</sub> S <sub>3</sub>	10,11
	O 1s	532.1	532.2	531.9	Adsorbed O <sub>2</sub> , H <sub>2</sub> O, etc.	12
Mo 3d	Mo 3d <sub>3/2</sub>	-	232.9	233.2	MoS <sub>2</sub>	13–15
		-	236.3	236.2	MoO <sub>3</sub> and/or MoO <sub>x</sub> O <sub>y</sub>	14,16–18
	Mo 3d <sub>5/2</sub>	-	229.8	230.0	MoS <sub>2</sub>	13–15
		-	233.2	233.0	MoO <sub>3</sub> and/or MoO <sub>x</sub> O <sub>y</sub>	14,16–18
	S 2s	232.8	-	-	S-N bond	19–21
		-	226.1	226.6	MoS <sub>2</sub>	14
S 2p	S 2p	168.5	-	-	S-N bond	19,20,22
		169.5	-	-	S-N bond	19,20,22
	S 2p <sub>3/2</sub>	-	161.4	161.8	S <sup>2-</sup> in MoS <sub>x</sub>	23,24
		-	162.6	163.1	S <sub>2</sub> <sup>2-</sup> in MoS <sub>x</sub>	23,24
		-	162.4	162.8	S <sup>2-</sup> in MoS <sub>x</sub>	23,24
		-	163.6	164.1	S <sub>2</sub> <sup>2-</sup> in MoS <sub>x</sub>	23,24
N 1s	N 1s	401.7	399.5	398.9	S-N bond	20,21,25
	Mo 3p <sub>3/2</sub>	-	395.8	396.1	MoS <sub>2</sub>	14

**Table S3.** Percentage error values for each circuit element to fit the complex-plane impedance diagrams obtained at  $-0.2$  V vs. Ag/AgCl/Cl<sup>-</sup><sub>(sat. KCl)</sub> and under solar light simulator (AM1.5G and  $100 \text{ mW cm}^{-2}$ ) for PT-Sb<sub>2</sub>S<sub>3</sub> and PT-Sb<sub>2</sub>S<sub>3</sub>/(1 min)-MoS<sub>x</sub> films. The electrolyte was an N<sub>2</sub>-saturated solution of  $1.0 \text{ mol L}^{-1}$  H<sub>2</sub>SO<sub>4</sub> at pH 0.6.

Circuit element	Percentage error <sup>a</sup> / %	
	PT-Sb <sub>2</sub> S <sub>3</sub>	PT-Sb <sub>2</sub> S <sub>3</sub> /(1 min)-MoS <sub>x</sub>
$R_s$	0.95	0.60
$R_{ct,sc}$	11	8.9
$R_{ct,d}$	5.4	5.2
$Q_{sc}$	6.8	3.8
$\alpha_{f,sc}$	5.7	1.4
$Q_d$	2.1	9.8
$\alpha_{f,d}$	0.32	0.70

<sup>a</sup>The fit of the complex-plane impedance diagrams for PT-Sb<sub>2</sub>S<sub>3</sub> and PT-Sb<sub>2</sub>S<sub>3</sub>/(1 min)-MoS<sub>x</sub> films delivered chi-squared ( $\chi^2$ ) values of 0.00048296 and 0.00022833, respectively.

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